## Notice of References Cited

Application/Control No. 10/700,704		Applicant(s)/Patent Under Reexamination YAN ET AL.		
Examiner	Art Unit			
Kaitlin S. Joerger	3653	Page 1 of 1		

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,540,088	04-2003	Oder et al.	209/218
	В	US-2,127,307	08-1938	ERICH OPPEN; et. al.	209/12.2
	C	US-3,292,786	12-1966	MIECZYSLAW KORZEKWA TADEUSZ	209/129
	D	US-4,172,028	10-1979	Dunn, John P.	209/12.2
	E	US-6,415,929	07-2002	Maehata et al.	209/12.2
	F	US-6,390,302	05-2002	Abrarov et al.	209/12.2
	G	US-2003/0196935	10-2003	Miles et al.	209/219
	Н	US-411,899	10-1889	Moffatt, R.	209/212
	ı	US-6,467,629	10-2002	Exner, Hurbertus	209/219
	J	US-			
	К	US-			
	٦	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Φ		-			
	ø					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.